

MBB800TV7A

Target Specification

Silicon N-channel IGBT

1. FEATURES

- * High speed, low loss IGBT module.
- * Low thermal impedance due to direct liquid cooling.
- * High reliability, high durability module.

2. ABSOLUTE MAXIMUM RATINGS (T_c=25°C)

| Item | Symbol | Unit | Specification |
|--|-------------------|------------------|---------------------|
| Collector Emitter Voltage | V _{CES} | V | 700 (4) |
| Gate Emitter Voltage | V _{GES} | V | ±20 |
| Collector Current | DC | I _C | 800 |
| | 1ms | I _{Cp} | 1600 |
| Forward Current | DC | I _F | 800 |
| | 1ms | I _{FM} | 1600 |
| Maximum Junction Temperature | T _{jmax} | °C | 175 |
| Temperature under switching conditions | T _{jop} | °C | -40 ~ +150 |
| Storage Temperature | T _{stg} | °C | -40 ~ +125 |
| Isolation Voltage | V _{ISO} | V _{RMS} | 2,500 (AC 1 minute) |
| Screw Torque | Terminals (M6) | - | 6.0 (1) |
| | Mounting (M5) | - | 4.0 (2) |
| | PCB Mounting (M3) | - | 0.8 (3) |

Notes: Recommended Value (1)5.5±0.5N·m, (2)3.5±0.5N·m, (3)0.65±0.15N·m.

(4)Please refer to figure of V_{CES} vs. T_c on the page of 6.

3. ELECTRICAL CHARACTERISTICS

| Item | Symbol | Unit | Min. | Typ. | Max. | Test Conditions | |
|--|------------------------|----------------------|------|------|------|---|--|
| Collector Emitter Cut-Off Current | I _{CES} | mA | - | - | 1.0 | V _{ce} =700V, V _{ge} =0V, T _j =25°C | |
| Gate Emitter Leakage Current | I _{GES} | nA | - | - | ±500 | V _{ge} =±20V, V _{ce} =0V, T _j =25°C | |
| Collector Emitter Saturation Voltage | V _{CE(sat)} | V | - | 1.55 | 2.0 | I _c =800A, V _{ge} =15V, T _j =25°C | |
| | | | - | 1.80 | - | I _c =800A, V _{ge} =15V, T _j =150°C | |
| Gate Emitter Threshold Voltage | V _{GE(TH)} | V | 6.0 | 6.7 | 7.5 | V _{ce} =5V, I _c =800mA, T _j =25°C | |
| Input Capacitance | C _{ies} | nF | - | 70 | - | V _{ce} =10V, V _{ge} =0V, f=100kHz, T _j =25°C | |
| Switching Times | Rise Time | t _r | - | 0.2 | 0.5 | V _{cc} =300V, I _c =800A | |
| | Turn On Time | t _{on} | - | 0.6 | 1.1 | L _s =30nH, R _{g(ext)} =4.7Ω, C _{ge} =56nF | |
| | Fall Time | t _f | - | 0.3 | 1.15 | V _{ge} =+15V/0V, T _j =150°C | |
| | Turn Off Time | t _{off} | - | 1.3 | 2.2 | Inductive load | |
| Peak Forward Voltage Drop | V _F | V | - | 1.35 | 1.7 | I _f =800A, V _{GE} =0V, T _j =25°C | |
| | | | - | 1.35 | - | I _f =800A, V _{GE} =0V, T _j =150°C | |
| Reverse Recovery Time | t _{rr} | μs | - | 0.4 | 0.85 | V _{CC} =300V, I _c =800A, | |
| Turn On Loss | E _{on(full)} | mJ/P | - | 20 | 33 | L _s =30nH, R _{g(ext)} =4.7Ω, C _{ge} =56nF | |
| Turn Off Loss | E _{off(full)} | mJ/P | - | 66 | 95 | V _{ge} =+15V/0V, T _j =150°C | |
| Reverse Recovery Loss | E _{rr(full)} | mJ/P | - | 22 | 42 | Inductive load | |
| Thermistor Resistance | R | kΩ | - | 5 | - | T _c =25°C | |
| | | | - | 0.16 | - | T _c =150°C | |
| Leakage Current between Thermistor and Other Terminals | | mA | - | - | 0.1 | V=600Vp | |
| Thermal Resistance | IGBT | R _{th(j-w)} | K/W | - | - | 0.135 | Junction to water/fin, 10l/min, 50%LLC |
| | FWD | R _{th(j-w)} | K/W | - | - | 0.165 | (per 1 arm) |

* Please contact our representatives at order.

* For improvement, specifications are subject to change without notice.

* For actual application, please confirm this spec sheet is the newest revision.

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4. PACKAGE OUTLINE DRAWING

Unit in mm

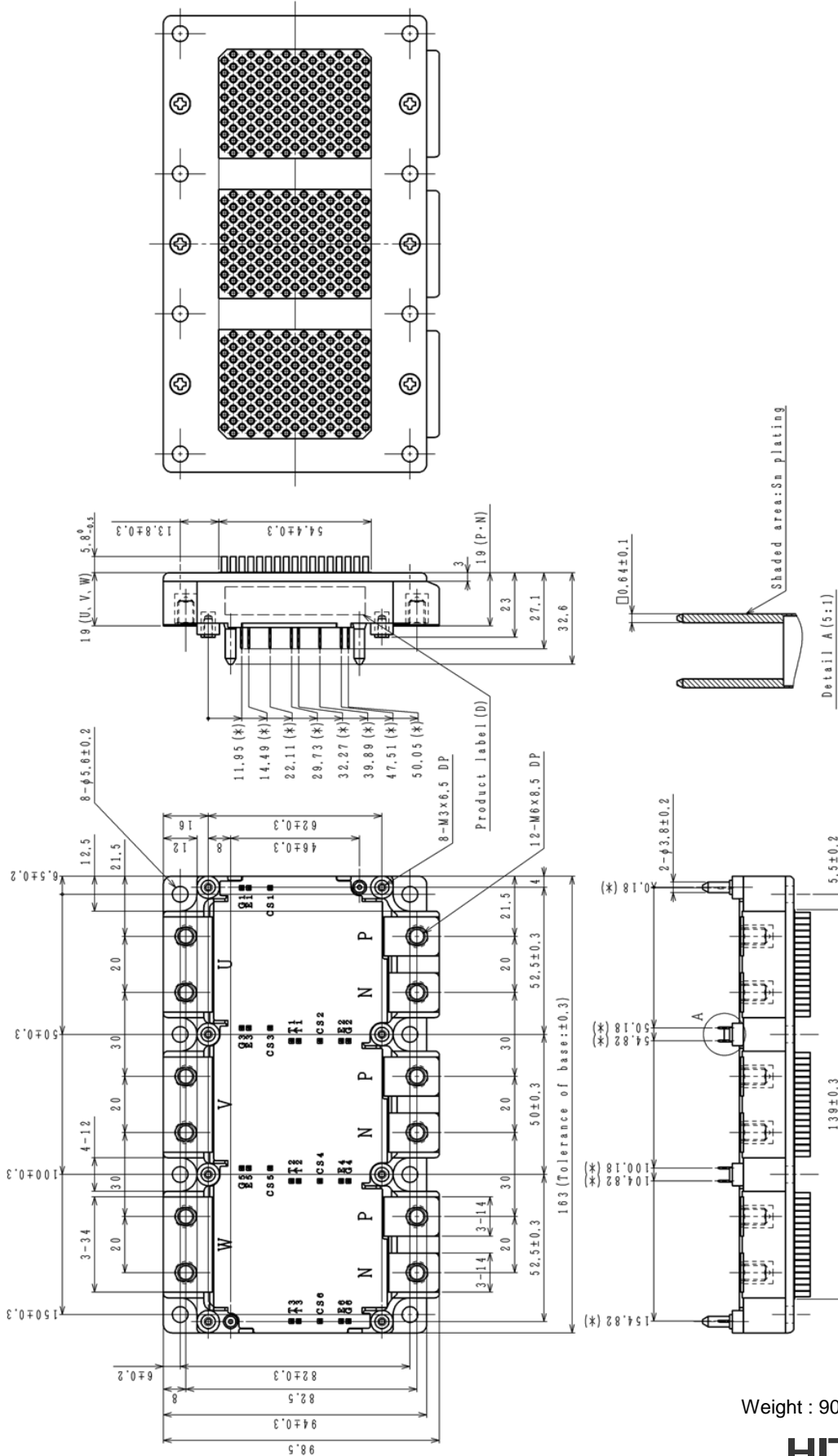


Table. Classification of basic dimension

| Classification of basic dimension(x) (unit:mm) | |
|--|-------------|
| 0.55(x)≤3 | 3<(x)≤6 |
| 30<(x)≤100 | 120<(x)≤400 |
| Tolerance ±0.2 | ±0.3 |
| | ±0.5 |
| | ±0.8 |
| | ±1.2 |

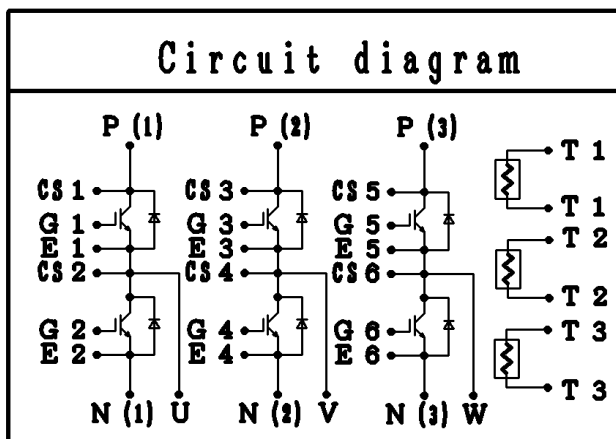
(Note 1) Dimension of (*) is that of the root portion of terminal. (Tolerance:±0.5)
 (Note 2) Dimensional tolerance follows the right table, if not described.

Weight : 900g

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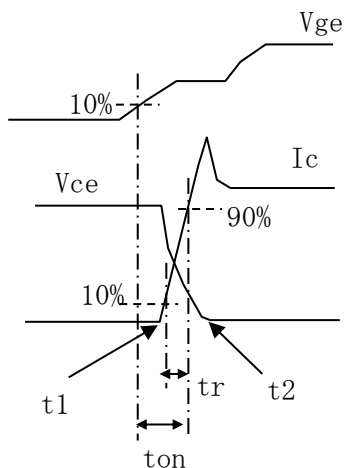
5. CIRCUIT DIAGRAM



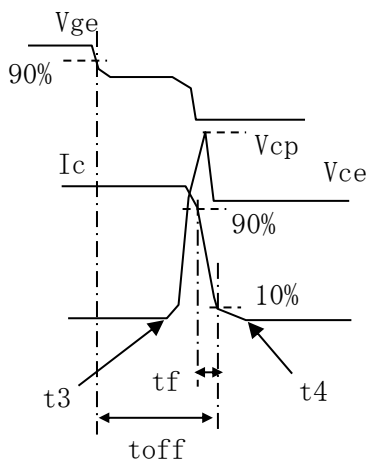
Thermistor T1, T2 and T3 are located on the same ceramic substrate with the IGBT and diode chips of phase U, V and W, respectively.

Note: This temperature measurement is not suitable for the short circuit or short term overload detection and should be used only for the module protection against long term overload or malfunction of the cooling system.

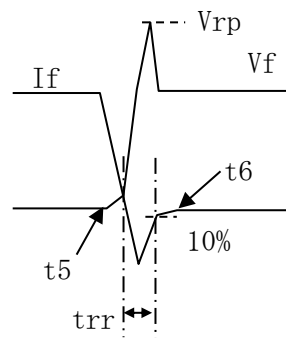
6. DEFINITION OF THE SYMBOLS



$$E_{on} = \int_{t1}^{t2} I_c \cdot V_{ce} dt$$



$$E_{off} = \int_{t3}^{t4} I_c \cdot V_{ce} dt$$

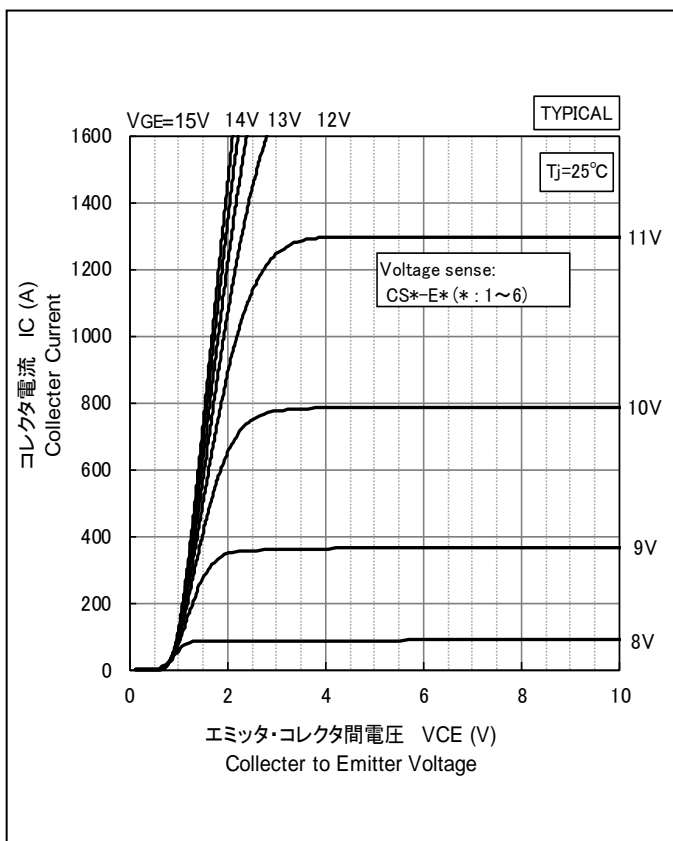


$$Err = - \int_{t5}^{t6} I_f \cdot V_f dt$$

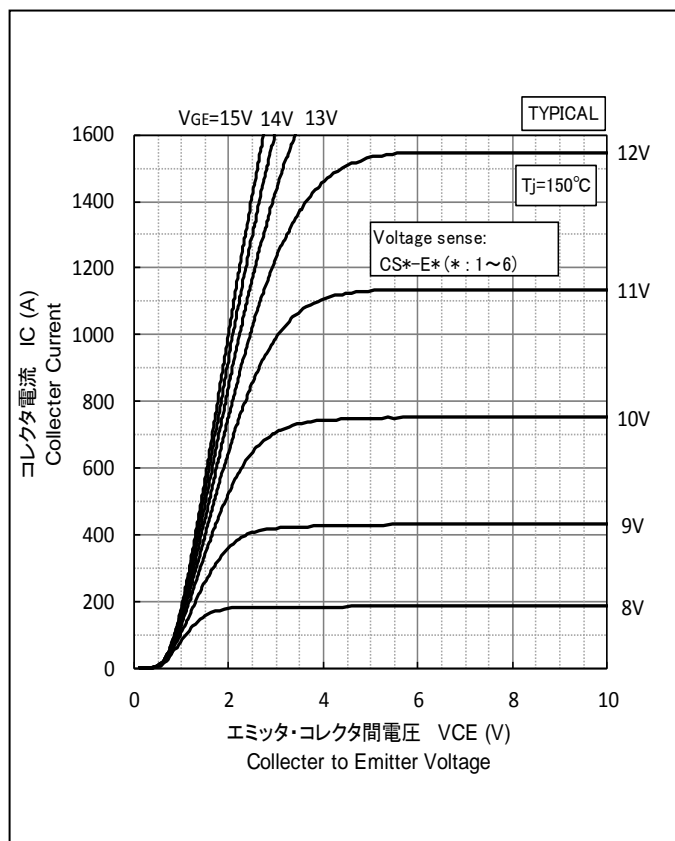
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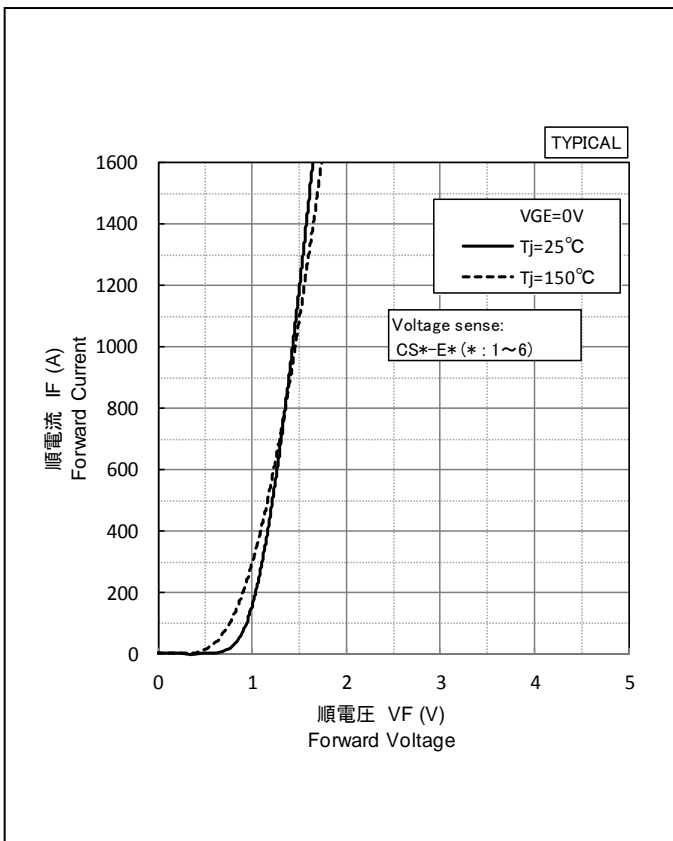
7. STATIC CHARACTERISTICS



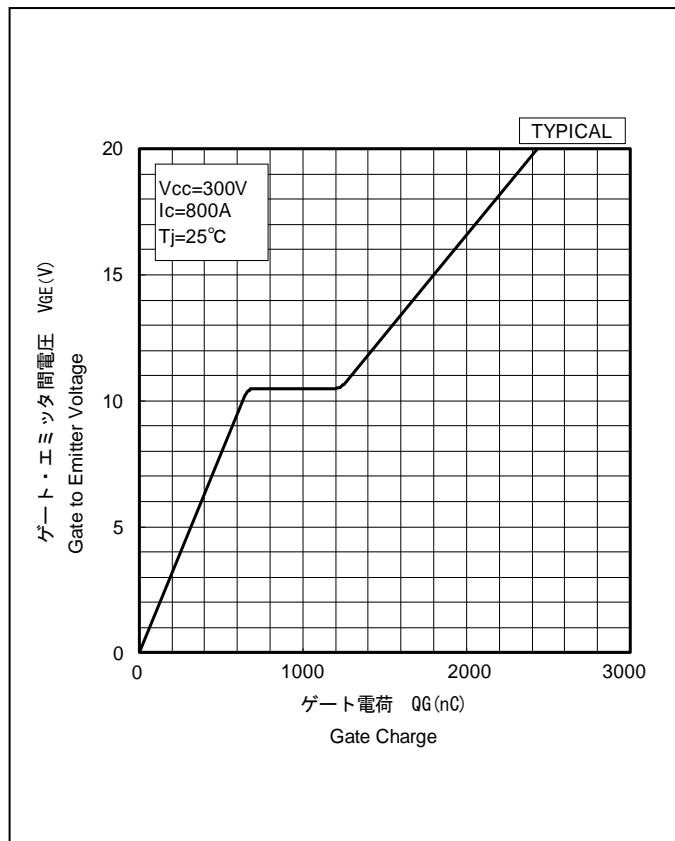
Collector Current vs. Collector to Emitter Voltage



Collector Current vs. Collector to Emitter Voltage



Forward Current vs. Forward Voltage

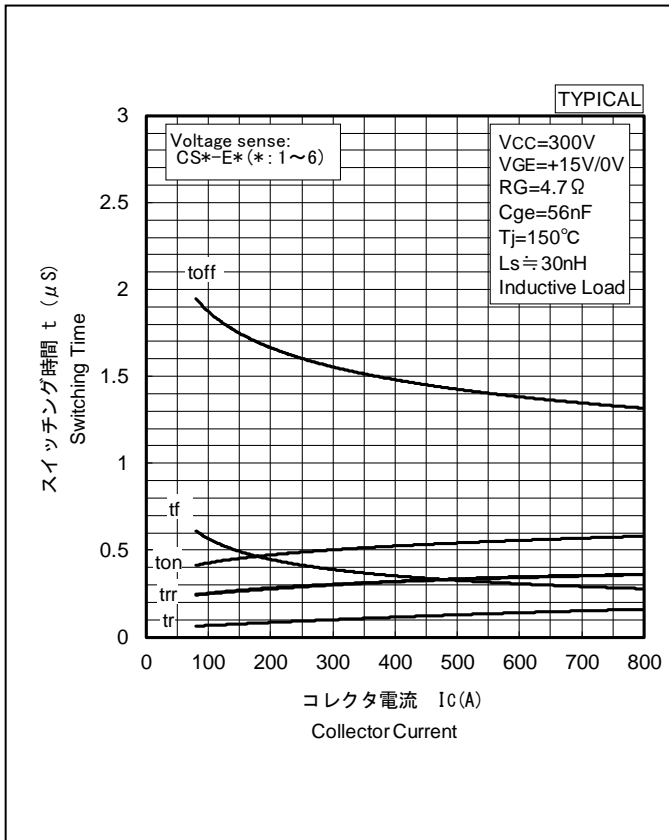


Gate to Emitter Voltage vs. Gate Charge

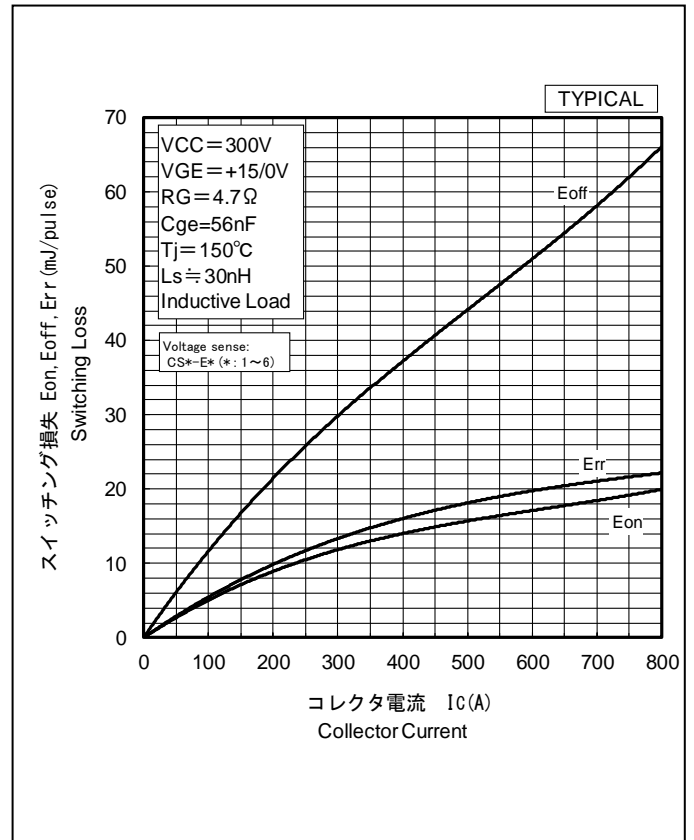
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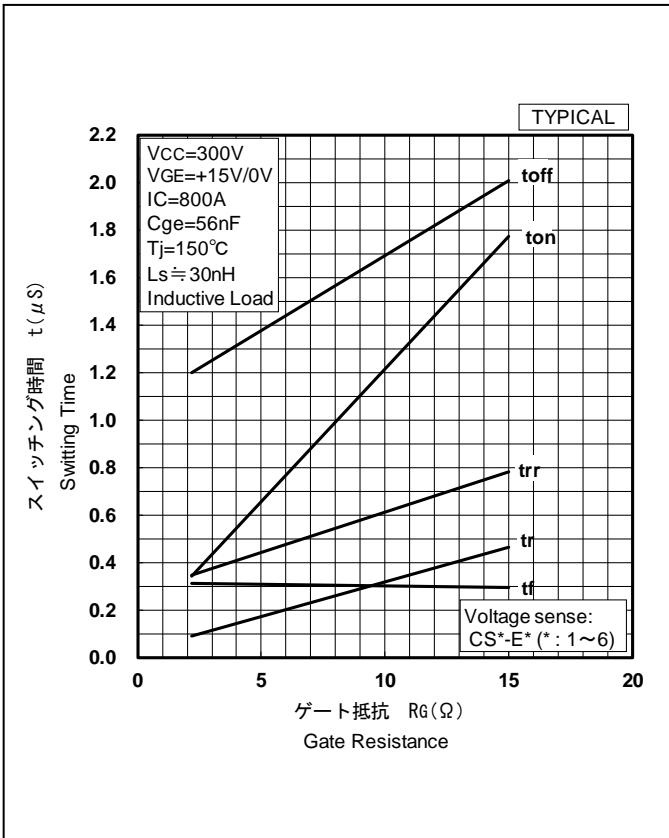
8. DYNAMIC CHARACTERISTICS



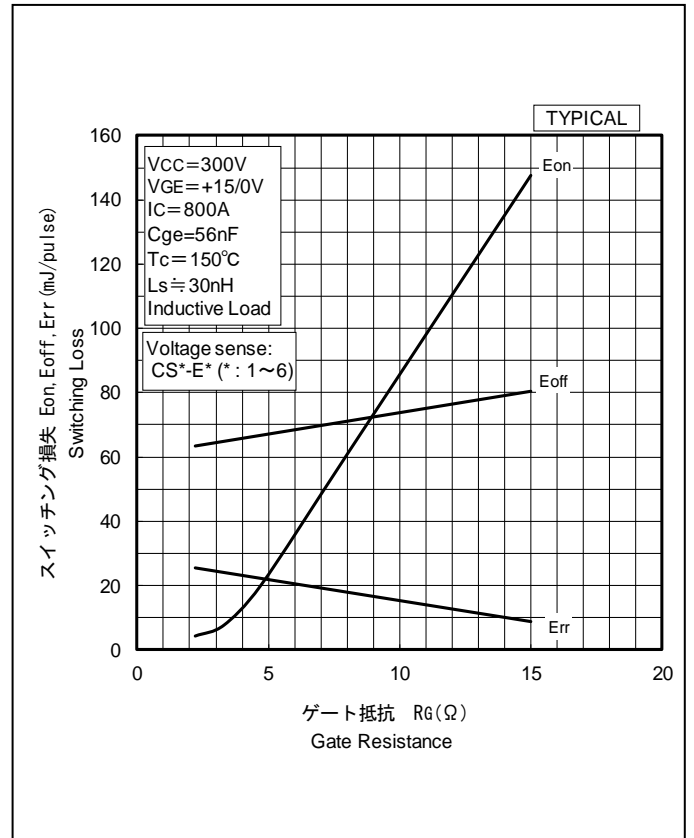
Switching Time vs. Collector Current



Switching Loss vs. Collector Current



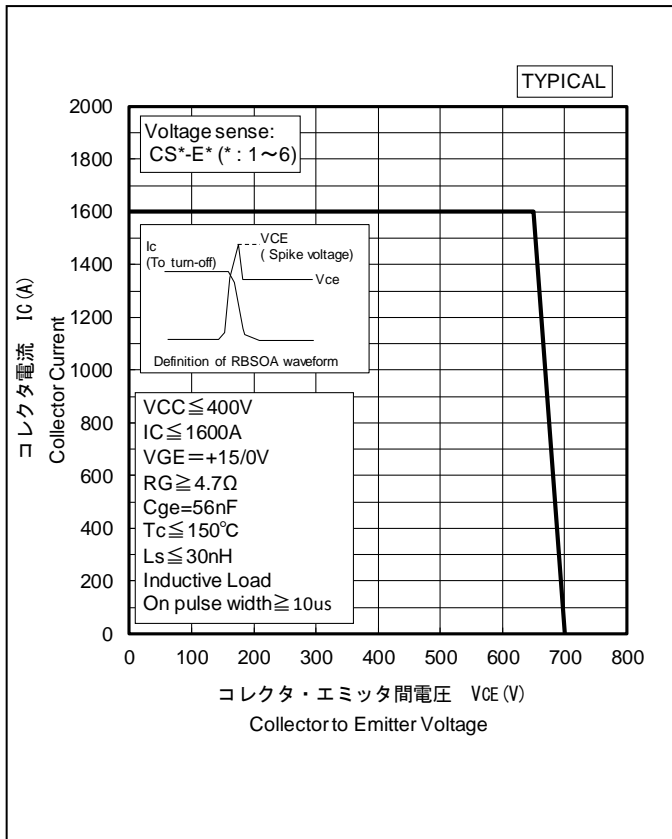
Switching Time vs. Gate Resistance



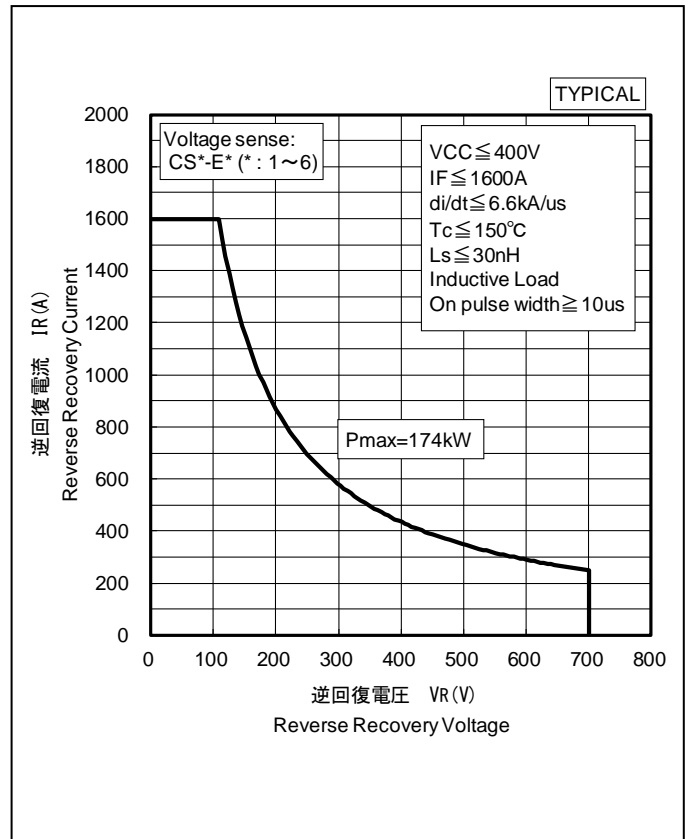
Switching Loss vs. Gate Resistance

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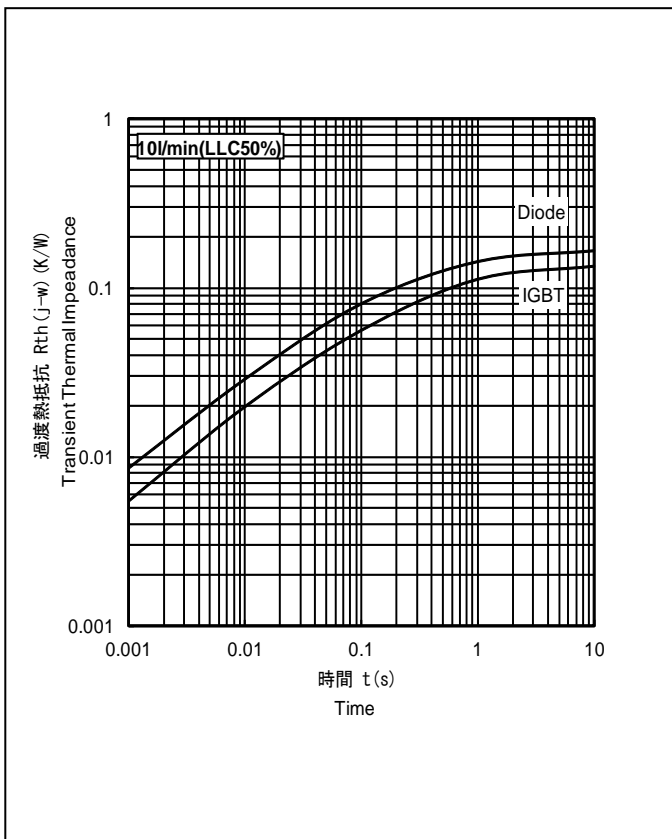
Target Specification



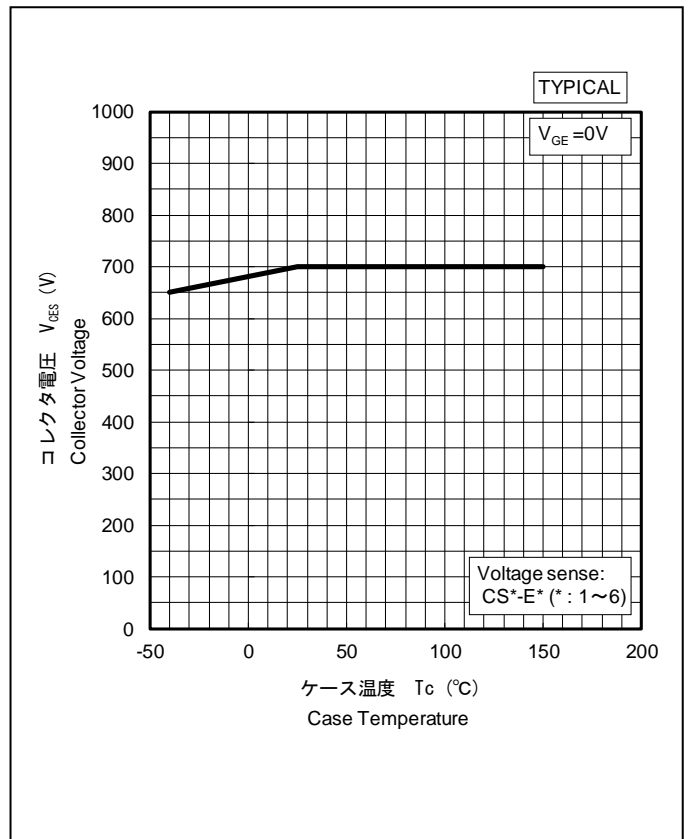
RBSOA



RRSOA



Transient Thermal Impedance Characteristics



V_{CES} vs. T_c

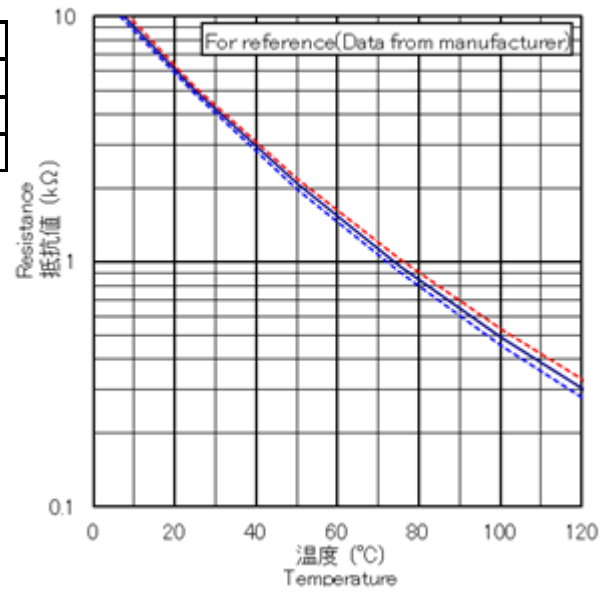
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9. THERMISTOR

Table1 Specifications of Thermistor(For reference)

| | |
|-------------------------------------|-----------------------------|
| Nominal zero-power resistance | 5k Ω \pm 3% (25°C) |
| B value | 3375K \pm 2% (25~50°C) |
| Operating temperature range | -50~150°C |
| Thermal time constant(in still air) | Approx. 10 sec. |



Resistance vs. Temperature

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10. PRECAUTIONS

10-1. Storage and Shipping Precautions

Important Notices

(1) IGBT modules should always be stored under the following conditions.

- Temperature : 40 degrees Celsius, maximum.
- Humidity : 60% Relative Humidity, maximum.
- Dust : Avoid storing the module in locations subject to dust.
- Harmful substances : The installation location should be free of corrosive gases such as sulfur dioxide and chlorine gas.
- Other : Do not remove the conductive sponges or tapes attached to the signal gate and emitter gate.

(2) Shipping Method

- To prevent the case cracking and/or the electrode bending, appropriate consideration should be given to properly insulate the shipping container from mechanical shock or sever vibration situation.
- Do not throw or drop the case while shipping. Treat them with care. The devices may break if they are not handled with care. Please do not use the IGBT modules that were dropped or damaged.
- Appropriate labeling on the outside of the shipping container should always be present.
- The shipping container itself should always be properly protected from both rain and water.

10-2. Precautions against Electrostatic Failure

Important Notices

Because the IGBT has a MOS gate structure and temperature sensing diode, you should always take the following precautions as measures to avoid generating static electricity.

- Before starting operation, do not remove the conductive sponge mounted between terminals of gate, emitter, collector, temperature sensing anode and cathode.
- When handling the IGBT module, ground our body via a high-value resistor (between 100kΩ and 1MΩ), hold the package body, and do not touch the terminals of gate, temperature sensing anode and cathode.
- Be sure to ground any parts which the IGBT module may touch, such as the work table or soldering iron.
- Before testing or inspection, be sure to check that any residual electric charge in measuring instruments has been removed. Apply voltage to each terminal starting at 0V and return to 0V when finishing.

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HITACHI POWER SEMICONDUCTORS

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